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CAPACITORS, CHIP, TANTALUM,

SOLID ELECTROLYTE,

BASED ON TYPE 1005

ESCC Detail Specification No. 3011/001

ISSUE 1 October 2002



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SOLID ELECTROLYTE,

BASED ON TYPE 1005

ESA/SCC Detail Specification No. 3011/001

space components coordination group

		Approved by				
lssue/Rev.	Date	SCCG Chairman	ESA Director General or his Deputy			
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Revision 'A'	September 1996	San mitter	Atom			
Revision 'B'	March 1998	\$a_mot	Hoom,			



Rev. 'B'

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DOCUMENTATION CHANGE NOTICE

Rev. Letter	Rev. Date	Reference	CHANGE Item	Approved DCR No.
'A'	Sept. '96	P1. Cover page P2. DCN P7. Figure 2 P9. Para. 4.4.1 P11. Table 2 Table 3	 In the Table, Variant Numbers adjusted Termination information clarified Table reformatted Table reformatted and Item 2 limit for +85°C corrected 	None None 221361 221361 221362 221362 221362
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<u>APPEN</u>	IDICES (applicable to specific Manufacturers only).	

None.



1. <u>GENERAL</u>

1.1 <u>SCOPE</u>

This specification details the ratings, physical and electrical characteristics, test and inspection data for Capacitors, Chip, Tantalum, Solid Electrolyte, based on Type 1005.

It shall be read in conjunction with ESA/SCC Generic Specification No. 3011, the requirements of which are supplemented herein.

1.2 RANGE OF COMPONENTS

The range of capacitors covered by this specification is scheduled in Table 1(a).

1.3 MAXIMUM RATINGS

The maximum ratings, which shall not be exceeded at any time during use or storage, applicable to the capacitors specified herein, are scheduled in Table 1(b).

1.4 PARAMETER DERATING INFORMATION

The parameter derating information applicable to the capacitors specified herein is shown in Figure 1.

1.5 PHYSICAL DIMENSIONS

The physical dimensions of the capacitors specified herein are shown in Figure 2.

1.6 FUNCTIONAL DIAGRAM

The functional diagram of the capacitors specified herein is shown in Figure 3.

Tolerance (%)	RATED VOLTAGE (V)
	50 50
10	40 25
and	20 16
20	10 6.3
	10 and

TABLE 1(a) - RANGE OF COMPONENTS



TABLE 1(b) - MAXIMUM RATINGS

NO			MAXIMUM	RATINGS		REMARKS	
NO.	CHARACTERISTICS	SYMBOL	MIN	MAX	UNITS		
1	Rated Voltage	Ur	See Tab	le 1(a)	Vdc		
2	Surge Voltage	Us	-	1.30 UR	Vdc		
3	Operating Temperature Range	Т _{ор}	-55	+ 125	°C		
4	Storage Temperature Range	T _{stg}	-55	+ 125	°C		
5	Soldering Temperature	T _{sol}	-	+ 260	°C	Soldering time: ≤10seconds	



VOLTAGE VERSUS TEMPERATURE

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 FIGURE 2 - PHYSICAL DIMENSIONS			,, <u>,,,</u> ,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,,



	DIMENSIONS (mm)									
	A		В		С		D		E	
	Min	Max	Min	Max	Min	Max	Min	Max	Min	Max
Variants 01 & 02	2.1	2.9	0.9	1.7	0.9	1.7	0.5	1.0	-	0.15
Variants 03 & 04	2.1	3.3	0.9	2.1	0.9	2.1	0.5	1.0	-	0.35

NOTES

1. The anode terminal shall be identified by the riser wire connection, which extends from the case size by 0.4mm max.

FIGURE 3 - FUNCTIONAL DIAGRAM



2. <u>APPLICABLE DOCUMENTS</u>

The following document forms part of this specification and shall be read in conjunction with it:-

(a) ESA/SCC Generic Specification No. 3011 for Capacitor, Chip, Tantalum, Solid Electrolyte.

3. TERMS, DEFINITIONS, ABBREVIATIONS, SYMBOLS AND UNITS

For the purpose of this specification, the terms, definitions, abbreviations, symbols and units specified in ESA/SCC Basic Specification No. 21300 shall apply.



4. <u>REQUIREMENTS</u>

4.1 <u>GENERAL</u>

The complete requirements for procurement of the capacitors specified herein are stated in this specification and ESA/SCC Generic Specification No. 3011. Deviations from the Generic Specification, applicable to this specification only, are listed in Para 4.2.

Deviations from the applicable Generic Specification and this Detail Specification, formally agreed with specific manufacturers on the basis that the alternative requirements are equivalent to the ESA/SCC requirements and do not affect the components' reliability, are listed in the appendices attached to this specification.

4.2 DEVIATIONS FROM GENERIC SPECIFICATION

The following deviations from ESA/SCC Generic Specification No. 3011 shall apply:-

- 4.2.1 <u>Deviations from Special In-process Controls</u> Not applicable.
- 4.2.2 <u>Deviations from Final Production Tests (Chart II)</u> None.
- 4.2.3 <u>Deviations from Burn-in Tests (Chart III)</u> None.
- 4.2.4 <u>Deviations from Qualification, Environmental and Endurance Tests (Chart IV)</u> None.
- 4.2.5 <u>Deviations from Lot Acceptance Tests (Chart V)</u> None.

4.3 MECHANICAL REQUIREMENTS

4.3.1 Dimension Check

The dimensions of the capacitors specified herein shall be verified in accordance with the requirements set out in Para 9.3 of ESA/SCC Generic Specification No. 3011 and shall conform to those shown in Figure 2 of this specification.

4.3.2 Weight

The maximum weight of the capacitors specified herein shall be 0.030 grammes.

4.3.3 Adhesion

The requirements for adhesion are specified in Para 9.3 of ESA/SCC Generic Specification No. 3011.

4.4 <u>Materials and Finishes</u>

The materials and finishes shall be as specified herein. Where a definite material is not specified, a material which will enable the capacitors specified herein to meet the performance requirements of this specification shall be used. Acceptance or approval of any constituent material does not guarantee acceptance of the finished product.



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4.4.2 Terminations

The capacitors shall be terminated in accordance with the requirements of ESA/SCC Basic Specification No. 23500, as follows:-

(a) Variant 01:

With clips or end caps Type 'E' with Type '2' finish.

(b) Variant 02:

With clips or end caps Type 'E' with Type '3' finish.

(c) Variant 03:

With pads of Silver Loaded Epoxy Resin with Type '2' finish.

(d) Variant 04:

With pads of Silver Loaded Epoxy Resin with Type '3' finish.

4.5 MARKING

4.5.1 General

The marking of all components delivered to this specification shall be in accordance with the requirements of ESA/SCC Basic Specification No. 21700 and the following subparagraphs. These components being too small to accommodate the marking as specified hereafter, the marking information in full shall accompany each component in its primary package. Such marking shall comprise:-

- (a) The SCC Component Number.
- (b) Electrical Characteristics and Ratings.
- (c) Traceability Information.

4.5.2 The SCC Component Number

The SCC component number shall be constituted and marked as follows:-

	<u>301100101B</u>
Detail Specification Number	
Type variant, (as applicable, see Para 4.4.1)	l
Testing level (B or C, as appropriate)	

4.5.3 Electrical Characteristics and Ratings

The electrical characteristics and ratings to be marked in the following order of precedence are:-

- (a) Numerical value.
- (b) Tolerance.
- (c) Rated voltage.

The information shall be constituted and marked as follows:

	155kG
Capacitance value (1.5µF)	
Tolerance, (10%)	
Rated voltage (25V)	



4.5.3.1 Capacitances

The capacitance values shall be expressed by means of the following codes. The unit quantity for marking shall be picofarads.

Numerical Value (%)	Code
XX104	XX4
XX10 ⁵	XX5
XX10 ⁶	XX6

4.5.3.2 Tolerances

The tolerance on numerical values shall be indicated by the letter code specified hereafter.

Tolerance (%)	Code letter
± 10	К
±20	M

4.5.3.3 Rated Voltage

The rated voltage shall be indicated by the code letter specified hereafter.

Rated Voltage (V)	Code letter
50	K
40	J
25	G
20	F
16	E
10	, D
6.3	А
4	М

4.5.4 Traceability Information

Traceability information shall be marked in accordance with the requirements of ESA/SCC Basic Specification No. 21700.

- (a) Manufacturing date code.
- (b) Manufacturer's name.

4.6 ELECTRICAL MEASUREMENTS

4.6.1 Electrical Measurements at Room Temperature

The parameters to be measured in respect of electrical characteristics are scheduled in Table 2. Unless otherwise specified, these measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

4.6.2 Electrical Measurements at High and Low Temperatures (Table 3)

The parameters to be measured at high and low temperatures are scheduled in Table 3.



4.6.3 Circuit for Electrical Measurements

Not applicable.

No.	Characteristics	Symbol	nbol ESA/SCC 3011 Test Conditions		Limits		Unit	Remarks	
110.	Characteristics	Зуший	Test Method		Min.	Max.	Unit	nemarks	
1	Capacitance	C _n	Para. 9.4.1.1	$V_T \le 0.5Vrms$ $V_P = 2.1 \text{ to } 2.5V$ $f = 100 \pm 5Hz$ or $f = 120 \pm 5Hz$	C _n -10 -20	C _n +10 +20	μF % %	See Table 1(a)	
2	D.C. Leakage Current	١Ľ	Para. 9.4.1.2	$V_T = U_R \pm 2\%$ Series Resistor = 1k Ω	-	(Note1)	μA		
3	Dissipation Factor	DF	Para. 9.4.1.3	f = 100 ± 5Hz or f = 120 ± 5Hz	-	6	%		

TABLE 2 - ELECTRICAL MEASUREMENTS AT ROOM TEMPERATURE

NOTES

1. 0.01C x U_R or 1.0, whichever is the greater.

TABLE 3 - ELECTRICAL MEASUREMENTS AT HIGH AND LOW TEMPERATURES

				_				
No.	Characteristics	Symbol	ESA/SCC 3011	Test Conditions		mits	Unit	Remarks
	onaraotonotioo	Cyntoor	Test Method	(Note 1)	Min.	Max.	0	Tiomanio
1	Capacitance	Cn	Para. 9.4.1.1	$\begin{array}{l} V_{T} \leq 0.5 Vrms \\ V_{P} = 2.1 \ to \ 2.5 V \\ f = 100 \pm 5 Hz \\ or \\ f = 120 \pm 5 Hz \\ - 55^{\circ}C, + 85^{\circ}C \\ + 125^{\circ}C \end{array}$	C _n -10 -15	C _n + 10 + 15	μF % %	See Table 1(a)
2	D.C. Leakage Current	ΙL	Para. 9.4.1.2	V _T = U _R ± 2% Series Resistor = 1kΩ + 85°C + 125°C	-	(Note 2) (Note 3)	μA	-
3	Dissipation Factor	DF	Para. 9.4.1.3	f = 100±5Hz or f = 120±5Hz - 55°C, +85°C, +125°C	-	8	%	

NOTES

- 1. Inspection Level II, Single Sampling, AQL 2.5% for each capacitance value. Each capacitance value shall be considered as constituting a complete lot.
- 2. 0.1C x U_R or 10, whichever is the greater.
- 3. 0.12C x U_R or 12, whichever is the greater.



4.7 <u>SELECTIVE LEVEL TESTING</u>

4.7.1 Parameter Drift Value

The parameter drift values applicable to burn-in are specified in Table 4 of this specification. Unless otherwise specified, these measurements shall be performed at $T_{amb} = +22 \pm 3$ °C.

The parameter drift value (Δ) applicable to the parameter scheduled shall not be exceeded. In addition to these drift value requirements for a given parameter, the appropriate limit value specified in Table 2 shall not be exceeded.

4.7.2 Conditions for Burn-in

The requirements for burn-in are specified in Section 7 of ESA/SCC Generic Specification No. 3011. The conditions for burn-in shall be as specified in Table 5 of this specification.

Upon completion of burn-in, a recovery period of 24 \pm 2 hours is necessary before performance of the end measurements.

4.7.3 Electrical Circuit for Burn-in

Not applicable.

No	CHARACTERISTICS	SYMBOL	TEST METHOD AND CONDITION	LIMITS	UNIT
1	Capacitance Change	ΔC/C	ESA/SCC No. 3011 Paras 9.4.2 & 9.4.1.1	±5	%
2	DC Leakage Change	ΔIL/IL	ESA/SCC No. 3011 Para 9.4.1.2.	 (1) + 200% of initial value measured or + (25% + 0.05μA) of limit value whichever is smaller 	%

TABLE 4 - PARAMETER DRIFT VALUES

NOTES

1. Leakage current \leq 0.1µA are considered as a 0.1µA value.

FIGURE 4 - TEST CIRCUIT (Not applicable)

TABLE 5 - CONDITIONS FOR BURN-IN

No	CHARACTERISTICS	SYMBOL	LIMITS	UNIT
1	Ambient Temperature	T _{amb}	+ 125	°C
2	Test Voltage	VT	0.66Ur	V
3	Duration	t	168	Hours

FIGURE 5 - ELECTRICAL CIRCUIT FOR BURN-IN (Not applicable)



4.8 ENVIRONMENTAL AND ENDURANCE TESTS

4.8.1 Measurements and Inspections on Completion of Environmental Tests

The parameters to be measured and inspections to be performed on completion of environmental testing shall be those specified in Table 6.

Unless otherwise specified, these measurements shall be performed at T_{amb} = +22 ± 3 °C.

4.8.2 Measurements and Inspections at Intermediate Points during Endurance Tests

The parameters to be measured at intermediate points during endurance tests are scheduled in Table 6.

4.8.3 Measurements and Inspections on Completion of Endurance Tests

The parameters to be measured and inspections to be performed on completion of endurance tests shall be those specified in Table 6. Unless otherwise specified, these measurements shall be performed at T_{amb} = +22 ± 3 °C.

4.8.4 Conditions for Operating Life Test (Part of Endurance Testing)

The requirements for operating life test are specified in Section 9 of ESA/SCC Generic Specification No. 3011. The conditions for operating life test shall be as specified in Table 7 of this specification.

4.8.5 <u>Electrical Circuit for Operating Life Test</u> Not applicable.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING

No.	ESA/SCC GENERIC S	SPEC. No. 3011	MEASUREMENTS AND	MEASUREMENTS AND INSPECTIONS			ITS	
	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	Max.	UNIT
01	Visual Inspection	Para. 9.1	Visual Inspection	ESA/SCC No. 20400	-	-	-	-
02	Mounting on Substrates	Para. 9.2	Final Measurements Capacitance D.C. Leakage Currrent Dissipation Factor Visual Examination	Table 2 Item 1 Table 2 Item 2 Table 3 Item 3 Good Tinning	C L DF	Table 2 I Table 2 Table 2 Table 2	ltem 2	
03	Adhesion	Para. 9.5	Final Examination Visual Examination Capacitance	No damage or loosening from substrate Table 2 Item 1	- C	- Table 2	- Item 1	-
04	Solderability	Para. 9.6	Visual Examination	No damage	-	-	-	-
05	Rapid Change of Temperature	Para. 9.7	Initial Measurements Capacitance Final Measurements	Table 2 Item 1 or value recorded in 02 After 4 hours minimum	с	Table 2	Item 1	
			Visual Examination	recovery No corrosion, mechanical damage or obliteration of marking	-	-	-	-
			Capacitance Change D.C. Leakage Current Dissipation Factor	Table 2 Item 1 Table 2 Item 2 Table 2 Item 3	ΔC/C I _L DF		+5.0 Item 2 Item 3	%
06	Vibration	Para. 9.8	Intermediate Measurements Electrical Measurements Final Examination	During last cycle Intermittent operation, intermittent contact, arcing, open or shorts	-	-	-	-
			Visual Examination	No damage	-	-	-	-
07	Shock or Bump	Para. 9.9	Final Examination Visual Examination	No damage	-	-		-
08	Climatic Sequence Dry Heat	Para. 9.10 Para. 9.10.2	Initial Measurements Capacitance Intermediate Measurements Capacitance Change	Value recorded in 02 At High Temperature Table 3 Item 1	с ∆с/с	Table 3	2 Item 1 3 Item 1	
	Cold Test Damp Heat	Para. 9.10.4 Para. 9.10.6	D.C. Leakage Current Intermediate Measurements Capacitance Change Final Measurements	Table 3 Item 2 At Low Temperature Table 3 Item 1 Recovery Period 1 to 24 hours	ι <u></u> Δc/c		3 Item 2 3 Item 1	
			Visual Inspection Capacitance Change D.C. Leakage Current Dissipation Factor	Gen. 3011, Para. 9.10.7 Table 2 Item 1 Table 2 Item 2 Table 2 Item 3	- ΔC/C IL DF	-10 Table 2 -	+ 10 2 item 2 Note 3	~

NOTES: See Page 15.



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TABLE 6 - MEASUREMENTS AND INSPECTIONS ON COMPLETION OF ENVIRONMENTAL TESTS AND AT INTERMEDIATE POINTS AND ON COMPLETION OF ENDURANCE TESTING (CONTINUED)

	ESA/SCC GENERIC	SPEC. No. 3011	MEASUREMENTS A	AND INSPECTIONS		LIM	ITS	
No.	ENVIRONMENTAL AND ENDURANCE TESTS (1)	TEST METHOD AND CONDITIONS	IDENTIFICATION	CONDITIONS	SYMBOL	MIN.	MAX.	UNIT
09	Damp Heat (Steady-State)	Para. 9.11 During 56 days	Initial Measurements Capacitance Final Measurements Visual Examination Capacitance Change D.C. Leakage Current Dissipation Factor	Value recorded in 02 Recovery Period 6 to 24 ± 2 hours No damage Table 2 Item 1 Table 2 Item 2 Table 2 Item 3	C ΔC/C ι_ DF	Table 2 - -10 Table 2 -	ltem 1 - + 10 ltem 2 Note 3	- %
10	High and Low Temperature Stability	Para. 9.12	Capacitance Change D.C. Leakage Current at all but Step 2 Dissipation Factor	Table 3 item 1 Table 3 item 2 Table 3 item 3	ΔC/C ι _L DF	Table 3	item 1 item 2 item 3	
11	Surge Voltage	Para. 9.13	Final Measurements Capacitance D.C. Leakage Current Dissipation Factor	After temperature stabilisation Table 2 Item 1 Table 2 Item 2 Table 2 Item 3	C IL DF	Table 2	ttem 1 ttem 2 ttem 3	
12	Operating Life	Para. 9.15	Initial Measurements Capacitance D.C. Leakage Current Dissipation Factor Intermediate Measurements D.C. Leakage Current Final Measurements Capacitance Change D.C. Leakage Current Dissipation Factor Visual Examination	Value recorded in 02 Table 2 Item 2 Table 2 Item 3 At 250 and 1000 hours At High Temperature Table 3 Item 2 At 1000 and 2000 hours and after 24 hours recovery Table 2 Item 1 Table 2 Item 1 Table 2 Item 2 At +25°C At +85°C At +125°C Table 2 Item 3 No damage	C Ι _L DF Ι <u></u> ΔC/C Ι _L DF	Table 2 Table 2 Table 3 -5.0 Table 2 Table 3 Table 3	2 Item 1 2 Item 2 2 Item 3 3 Item 2 4 +5.0 2 Item 2 3 Item 2 3 Item 2 2 Item 3 4 Item 3	%
13	Permanence of Marking	Para. 9.17	Final Examination Visual Examination	ESA/SCC No. 24800	-	-		-

NOTES

- 1. The tests in this Table refer to either Chart IV or V and shall be used as applicable.
- 2. Value to be recorded.
- 3. 1.2 x value specified in Table 2 Item 3.



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No	CHARACTERISTICS	SYMBOL	CONDITION	UNIT
1	Ambient Temperature	T _{amb}	+ 85°C + 125°C	°C
2	Test Voltage	Ur	Rated Voltage (1) Derated Voltage	Vdc

NOTES

 The test voltage shall be the rated voltage (see Table 1(a)) for +85°C ambient temperature and the derated voltage (see Figure 1) for +125°C ambient temperature.